



SEMITRANS® 2

## IGBT4 Modules

### SKM75GB17E4H16

#### Features

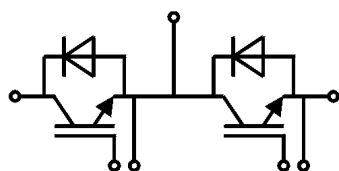
- **H16: IGBT-chip with improved robustness against moisture**
- IGBT4 = 4. generation medium fast trench IGBT (Infineon)
- CAL4 = Soft switching 4. Generation CAL-Diode
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated Gate resistor
- For switching frequencies up to 8kHz
- UL recognized, file no. E63532

#### Typical Applications\*

- Medium voltage inverter market

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$



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#### Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1700	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	132	A
		T <sub>c</sub> = 80 °C	100	A
I <sub>Cnom</sub>			75	A
I <sub>CRM</sub>	I <sub>CRM</sub> = 3xI <sub>Cnom</sub>		225	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>pSC</sub>	V <sub>CC</sub> = 1000 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 1700 V	T <sub>j</sub> = 150 °C	10	μs
T <sub>j</sub>			-40 ... 175	°C

#### Inverse diode

V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1700	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	88	A
		T <sub>c</sub> = 80 °C	65	A
I <sub>Fnom</sub>			75	A
I <sub>FRM</sub>	I <sub>FRM</sub> = 2xI <sub>Fnom</sub>		150	A
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		510	A
T <sub>j</sub>			-40 ... 175	°C

#### Module

$I_{t(RMS)}$		200	A
$T_{stg}$		-40 ... 125	$^\circ\text{C}$
$V_{isol}$	AC sinus 50 Hz, $t = 1\text{ min}$	4000	V

#### Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 75 A	T <sub>j</sub> = 25 °C		1.93	2.25	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.28	2.53	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.10	1.20	V
		T <sub>j</sub> = 150 °C		1.00	1.10	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C		11	14	mΩ
	chiplevel	T <sub>j</sub> = 150 °C		17	19	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 2.8 mA		5.2	5.8	6.4	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1700 V, T <sub>j</sub> = 25 °C				1	mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		5.5		nF
C <sub>oes</sub>		f = 1 MHz		0.23		nF
C <sub>res</sub>		f = 1 MHz		0.18		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V...+ 15 V			600		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			16		Ω
t <sub>d(on)</sub>	V <sub>CC</sub> = 1200 V	T <sub>j</sub> = 150 °C		250		ns
t <sub>r</sub>	I <sub>C</sub> = 75 A	T <sub>j</sub> = 150 °C		39		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		37		mJ
t <sub>d(off)</sub>	R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		700		ns
t <sub>f</sub>	R <sub>G off</sub> = 1 Ω	T <sub>j</sub> = 150 °C		150		ns
	di/dt <sub>on</sub> = 1724 A/μs	T <sub>j</sub> = 150 °C				
E <sub>off</sub>	di/dt <sub>off</sub> = 465 A/μs	T <sub>j</sub> = 150 °C		29		mJ
R <sub>th(j-c)</sub>	per IGBT				0.304	K/W
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0.81 W/(m²K))			0.127		K/W



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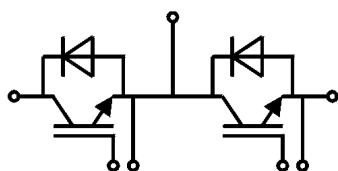
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#### Remarks

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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 75 A	T <sub>j</sub> = 25 °C		2.00	2.40	V
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.14	2.56	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.32	1.56	V
		T <sub>j</sub> = 150 °C		1.08	1.22	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		9.1	11	mΩ
		T <sub>j</sub> = 150 °C		14	18	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 75 A	T <sub>j</sub> = 150 °C		95		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 1484 A/μs	T <sub>j</sub> = 150 °C		27		μC
E <sub>rr</sub>	V <sub>GE</sub> = ±15 V V <sub>CC</sub> = 1200 V	T <sub>j</sub> = 150 °C		18		mJ
R <sub>th(j-c)</sub>	per diode				0.632	K/W
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.143		K/W
Module						
L <sub>CE</sub>				30		nH
R <sub>CC'+EE'</sub>	measured per	T <sub>C</sub> = 25 °C		0.65		mΩ
	switch	T <sub>C</sub> = 125 °C		1.09		mΩ
R <sub>th(c-s)1</sub>	calculated without thermal coupling (λ <sub>grease</sub> =0.81 W/(m*K))			0.034		K/W
R <sub>th(c-s)2</sub>	including thermal coupling, Ts underneath module (λ <sub>grease</sub> =0.81 W/(m*K))			0.05		K/W
M <sub>s</sub>	to heat sink M6		3		5	Nm
M <sub>t</sub>		to terminals M5	2.5		5	Nm
						Nm
w					160	g



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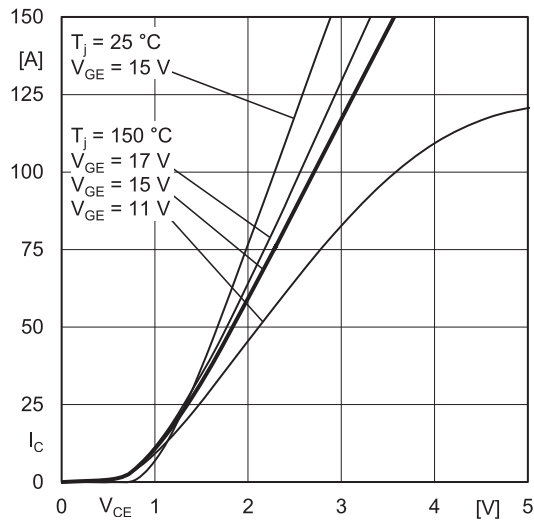


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+EE'}$

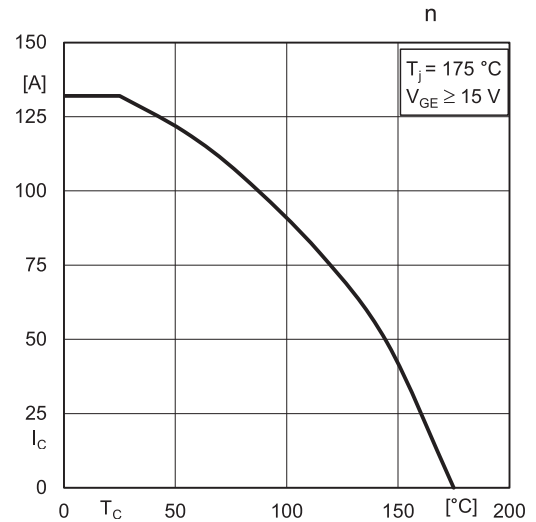


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

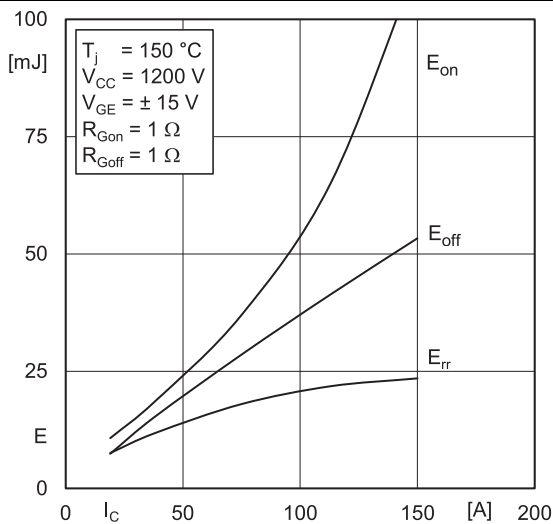


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

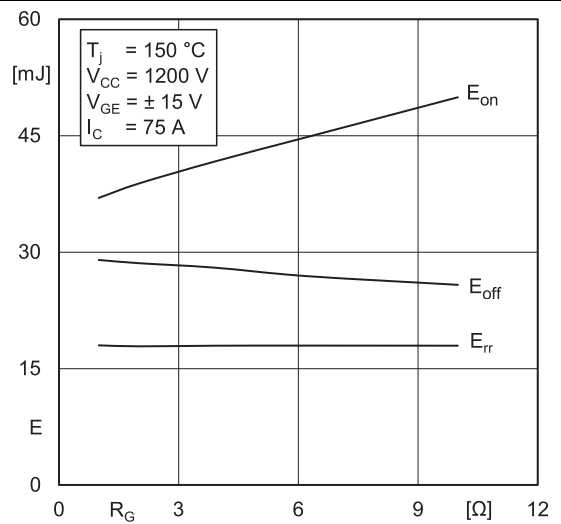


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

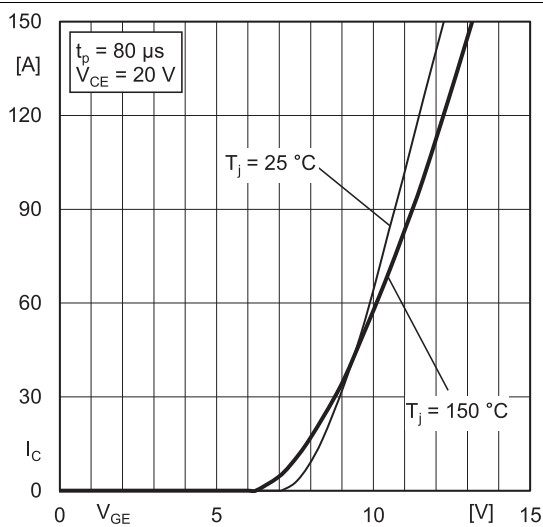


Fig. 5: Typ. transfer characteristic

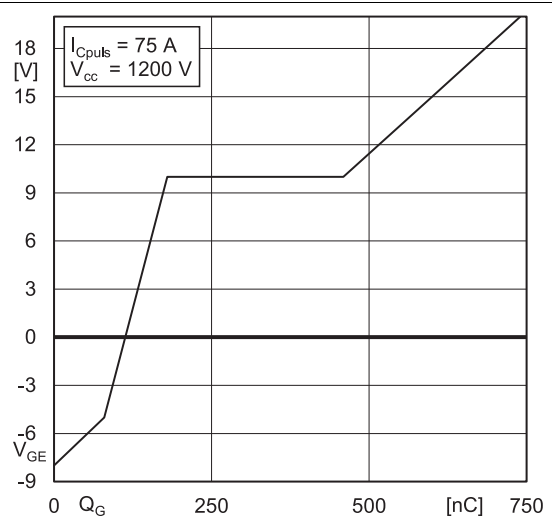


Fig. 6: Typ. gate charge characteristic

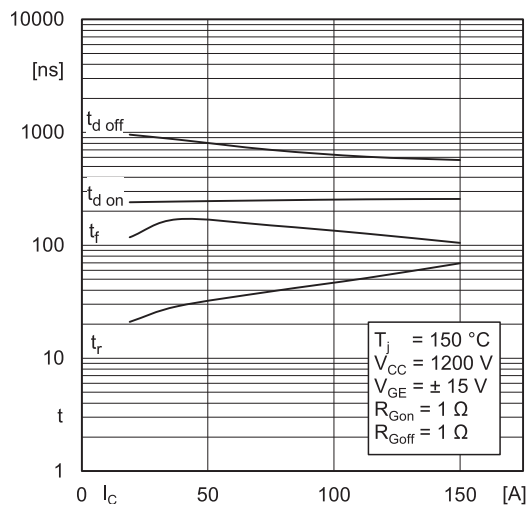


Fig. 7: Typ. switching times vs.  $I_C$

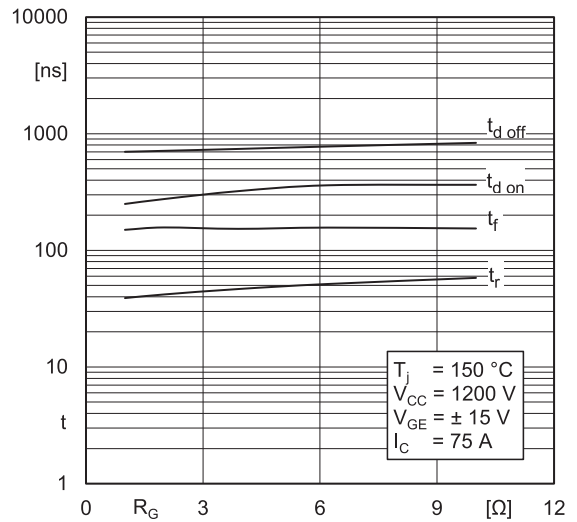


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

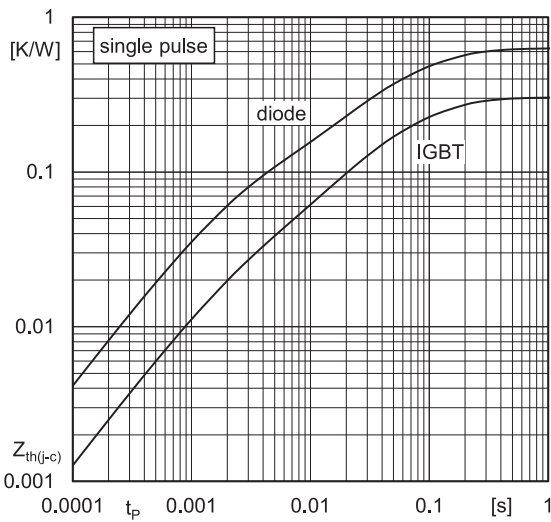


Fig. 9: Transient thermal impedance

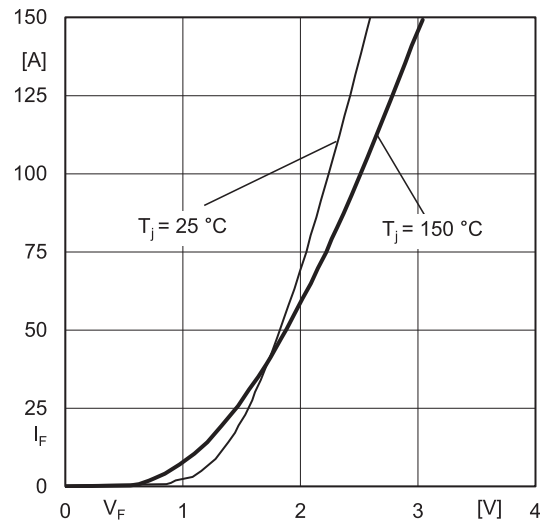


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC'+EE'}$

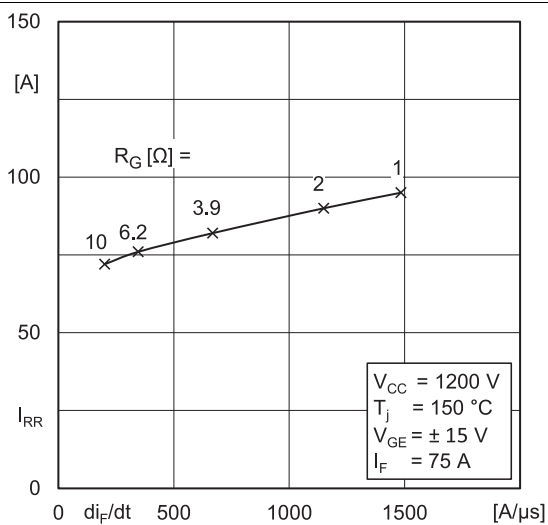


Fig. 11: CAL diode peak reverse recovery current

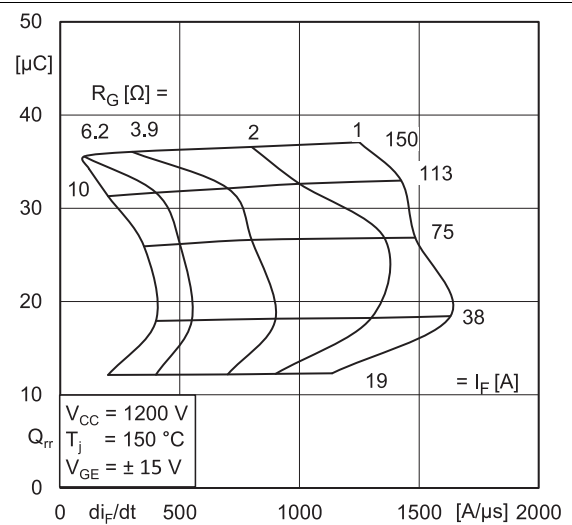
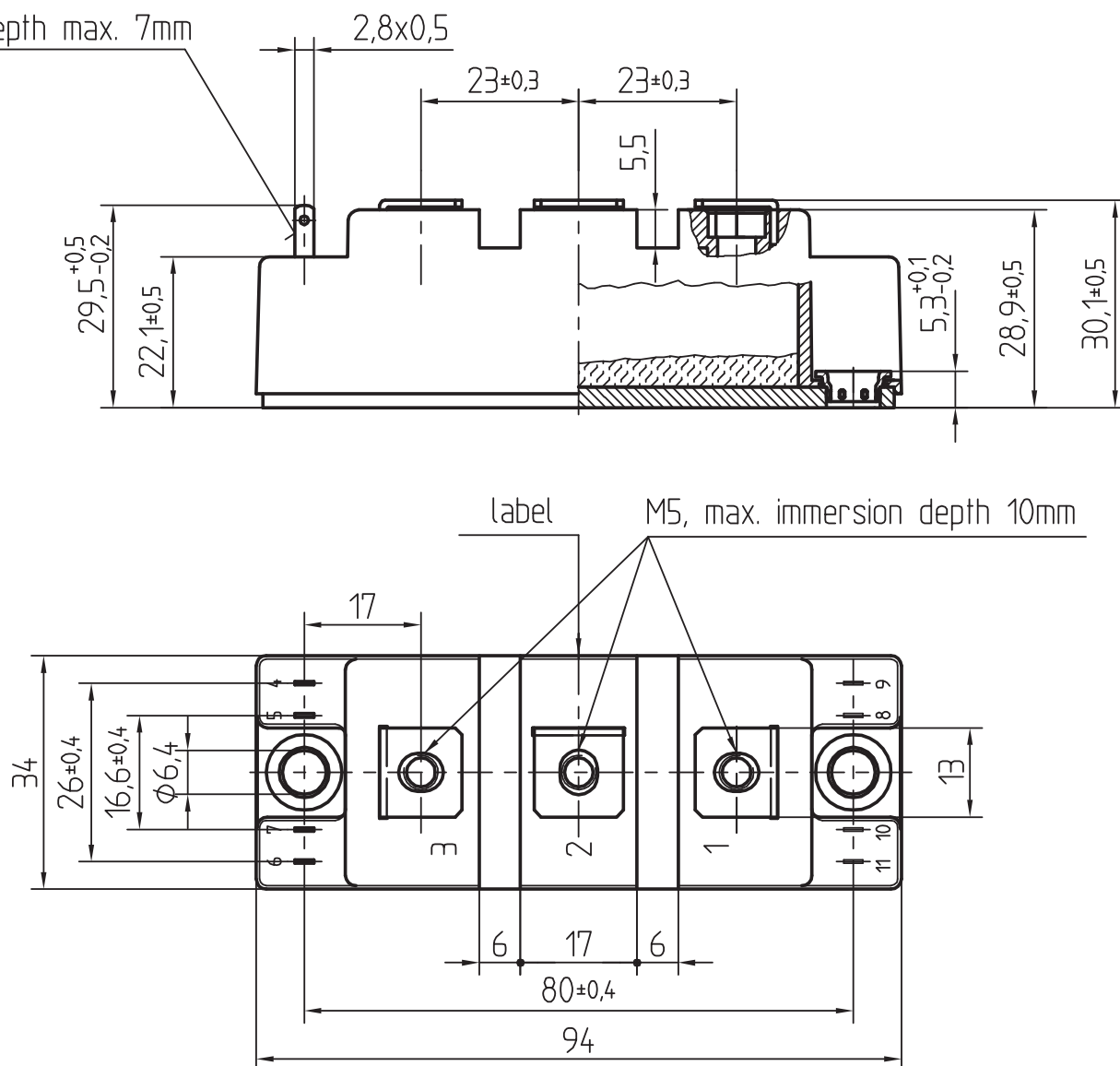


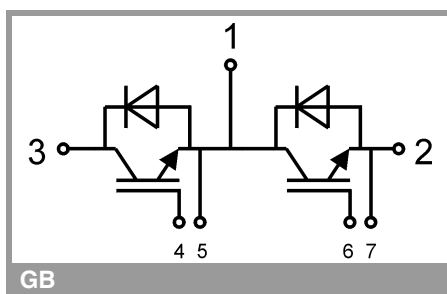
Fig. 12: Typ. CAL diode peak reverse recovery charge

Dimensions in mm

Plug in depth max. 7mm



General tolerance  $\pm 0,5$  mm



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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